

0CX0 Part No.: 0S400-1005-012

Issue 2; 11th May 2022

Features

- Temperature stability to ±5ppb
- Low phase noise
- Frequency 10.00MHz
- Industry standard package
- The flexible nature of the design means that variations to suit almost any application can be developed to meet individual customer requirements

Option A

- Temperature stability: ±5ppb over (0 to +50)^oC
- Output: Sinewave OdBm nominal
- Harmonics: -20dBc
- Voltage: 5.0V
- Warm Up Current: 470mA
- Quiescent current: 220mA

Phase Noise (typical)

- F0₀+10Hz -130 dBc/Hz
- F0₀+100Hz -150 dBc/Hz
- F0₀+1KHz -160 dBc/Hz
- F0₀+10KHz -168 dBc/Hz
- F0₀+100KHz -175 dBc/Hz

Values based on a 10MHz unit

Voltage / Load change

- ±5% supply voltage change: ±2ppb
- ±10% load change: ±10ppb

Ageing

Bases on 10MHz unit after 30 days continuous operation:

- Per day: ±0.7ppb max.
- Per year: ±200ppb max.
- Warm up time: 5 minutes to within 0.1ppm

Voltage Trim

- ±0.5ppm minimum
- Trim impedance 50KΩ

Reference Options

3.0V

Environmental

- Electrostatic-Sensitive Device (ESD)
- Storage Temperature Range: (-40 to +125)°C



Dimensions (mm)





Phase Noise Plot







- Mechanical shock: MIL standard 202F, method 213, condition J
- Thermal shock: MIL standard 202F, method 107, condition A
- Vibration: MIL standard 202F, method 204, condition B
- Solderability: 5 seconds maximum at 230°C
- 3 seconds maximum at 350°C

Compliance

- RoHS Status (2011/65/EU) Compliant
- REACH Status Compliant

Packaging

Pack Style: Bulk

Ordering Information

- 0CX0 Part No.: 0S400-1005-012
- Frequency: 10.00MHz
- Stability/Output/Voltage: Option A

Test Circuit - Sinewave

